

**Search Notes**

Application/Control No.

10/777,026

Examiner

Binh X. Tran

Applicant(s)/Patent under  
Reexamination

KAWAGUCHI ET AL.

Art Unit

1765

**SEARCHED**

Class	Subclass	Date	Examiner
216	68	2/9/2007	BT
216	69	2/9/2007	BT
216	73	2/9/2007	BT
438	715	2/9/2007	BT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated search using databases in EAST	2/9/2007	BT